



General Description

FSMOS[®] MOSFET is based on Oriental Semiconductor's unique device design to achieve low $R_{DS(ON)}$, low gate charge, fast switching and excellent avalanche characteristics. The high V_{th} series is specially designed to use in power supply systems with driving voltage of more than 10V.

Features

- Low $R_{DS(ON)}$ & FOM
- Extremely low switching loss
- Excellent reliability and uniformity
- Fast switching and soft recovery



Applications

- PD charger
- Motor driver
- Switching voltage regulator
- DC-DC convertor
- Switching mode power supply

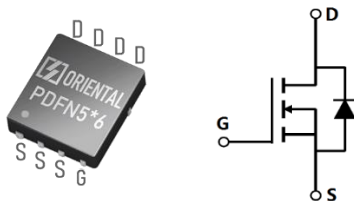
Key Performance Parameters

Parameter	Value	Unit
V_{DS}	250	V
I_D , pulse	140	A
$R_{DS(ON)}$, max @ $V_{GS}=10V$	60	m Ω
Q_g	64	nC

Marking Information

Product Name	Package	Marking
SFS25R60GNF	PDFN5×6	SFS25R60GN

Package & Pin information



Absolute Maximum Ratings at $T_j=25^{\circ}\text{C}$ unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	250	V
Gate-source voltage	V_{GS}	± 20	V
Continuous drain current ¹⁾ , $T_C=25^{\circ}\text{C}$	I_D	35	A
Pulsed drain current ²⁾ , $T_C=25^{\circ}\text{C}$	$I_{D, \text{pulse}}$	140	A
Continuous diode forward current ¹⁾ , $T_C=25^{\circ}\text{C}$	I_S	35	A
Diode pulsed current ²⁾ , $T_C=25^{\circ}\text{C}$	$I_{S, \text{pulse}}$	140	A
Power dissipation ³⁾ , $T_C=25^{\circ}\text{C}$	P_D	160	W
Single pulsed avalanche energy ⁵⁾	E_{AS}	66	mJ
Operation and storage temperature	T_{stg}, T_j	-55 to 150	$^{\circ}\text{C}$

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal resistance, junction-case	$R_{\theta JC}$	0.78	$^{\circ}\text{C/W}$
Thermal resistance, junction-ambient ⁴⁾	$R_{\theta JA}$	62	$^{\circ}\text{C/W}$

Electrical Characteristics at $T_j=25^{\circ}\text{C}$ unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Drain-source breakdown voltage	BV_{DSS}	250			V	$V_{GS}=0\text{ V}, I_D=250\text{ }\mu\text{A}$
Gate threshold voltage	$V_{GS(th)}$	3		4.5	V	$V_{DS}=V_{GS}, I_D=250\text{ }\mu\text{A}$
Drain-source on-state resistance	$R_{DS(ON)}$		47	60	m Ω	$V_{GS}=10\text{ V}, I_D=20\text{ A}$
Gate-source leakage current	I_{GSS}			100	nA	$V_{GS}=20\text{ V}$
				-100		$V_{GS}=-20\text{ V}$
Drain-source leakage current	I_{DSS}			1	μA	$V_{DS}=250\text{ V}, V_{GS}=0\text{ V}$
Gate resistance	R_G		2.6		Ω	$f=1\text{ MHz}$, Open drain

Dynamic Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Input capacitance	C_{iss}		5040		pF	$V_{GS}=0\text{ V}$, $V_{DS}=25\text{ V}$, $f=100\text{ kHz}$
Output capacitance	C_{oss}		318		pF	
Reverse transfer capacitance	C_{rss}		13		pF	
Turn-on delay time	$t_{d(on)}$		23		ns	$V_{GS}=10\text{ V}$, $V_{DS}=100\text{ V}$, $R_G=2\ \Omega$, $I_D=25\text{ A}$
Rise time	t_r		14		ns	
Turn-off delay time	$t_{d(off)}$		41		ns	
Fall time	t_f		8		ns	

Gate Charge Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Total gate charge	Q_g		64		nC	$V_{GS}=10\text{ V}$, $V_{DS}=100\text{ V}$, $I_D=25\text{ A}$
Gate-source charge	Q_{gs}		28		nC	
Gate-drain charge	Q_{gd}		10		nC	
Gate plateau voltage	$V_{plateau}$		5.9		V	

Body Diode Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Diode forward voltage	V_{SD}			1.3	V	$I_S=20\text{ A}$, $V_{GS}=0\text{ V}$
Reverse recovery time	t_{rr}		177		ns	$V_R=100\text{ V}$, $I_S=25\text{ A}$, $di/dt=80\text{ A}/\mu\text{s}$
Reverse recovery charge	Q_{rr}		987		nC	
Peak reverse recovery current	I_{rrm}		11		A	

Note

- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3) P_d is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_a=25\text{ }^{\circ}\text{C}$.
- 5) $V_{DD}=50\text{ V}$, $V_{GS}=10\text{ V}$, $L=0.3\text{ mH}$, starting $T_j=25\text{ }^{\circ}\text{C}$.

Electrical Characteristics Diagrams

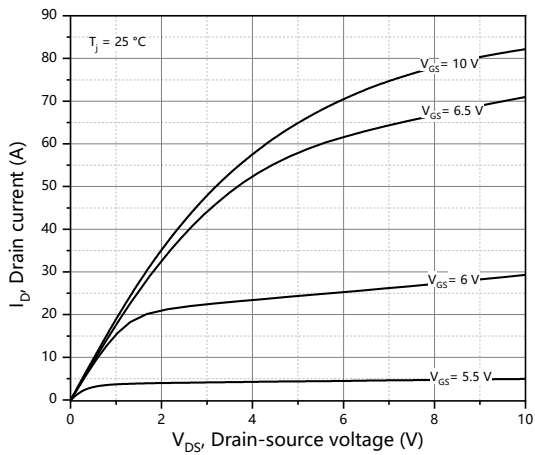


Figure 1. Typ. output characteristics

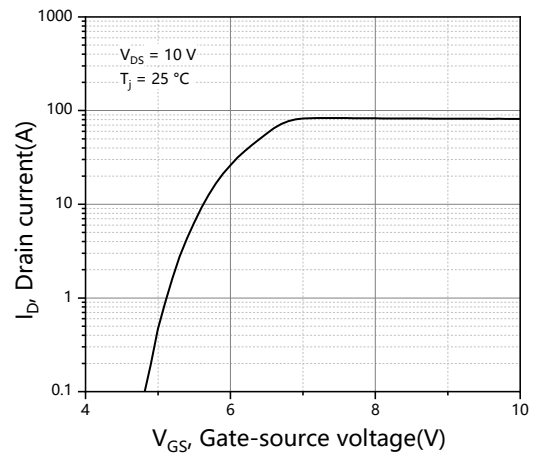


Figure 2. Typ. transfer characteristics

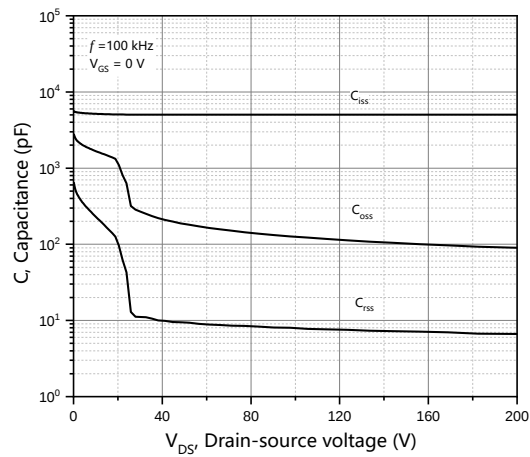


Figure 3. Typ. capacitances

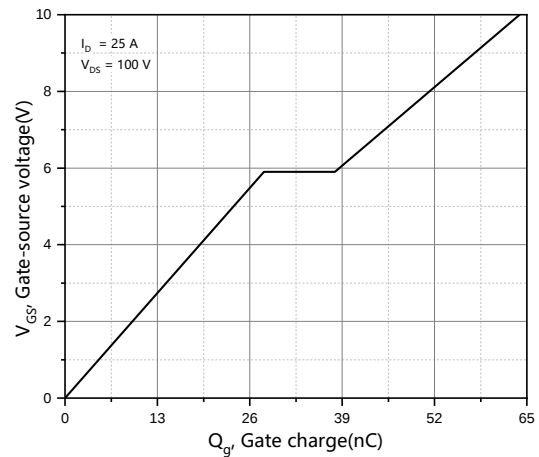


Figure 4. Typ. gate charge

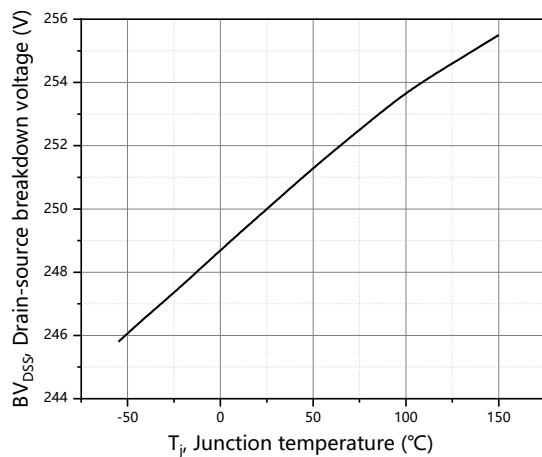


Figure 5. Drain-source breakdown voltage

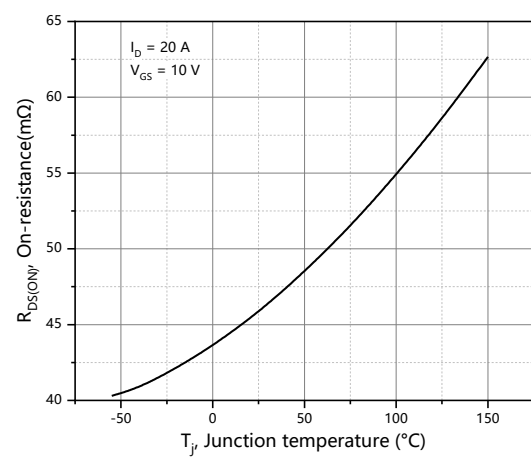


Figure 6. Drain-source on-state resistance

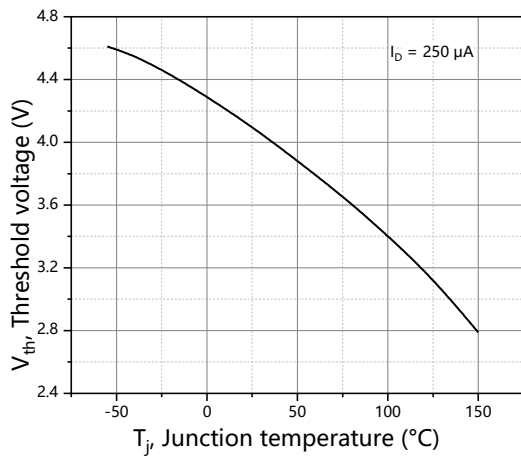


Figure 7. Threshold voltage

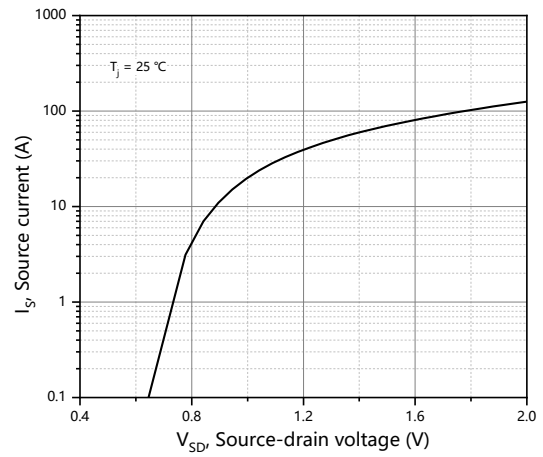


Figure 8. Forward characteristic of body diode

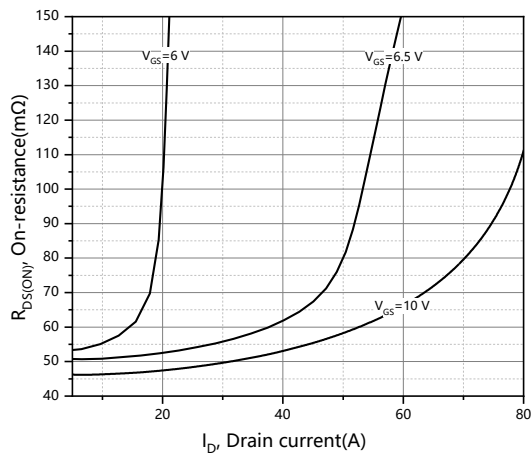


Figure 9. Drain-source on-state resistance

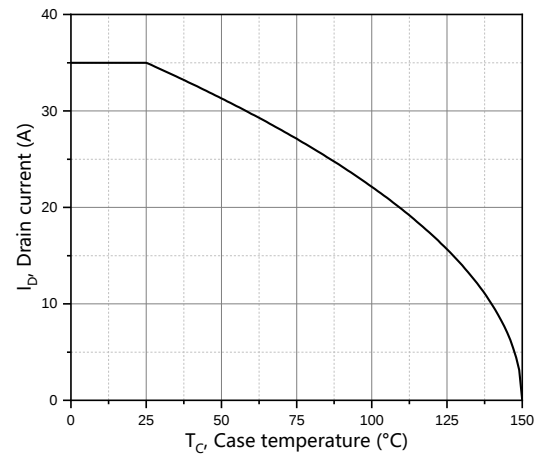


Figure 10. Drain current

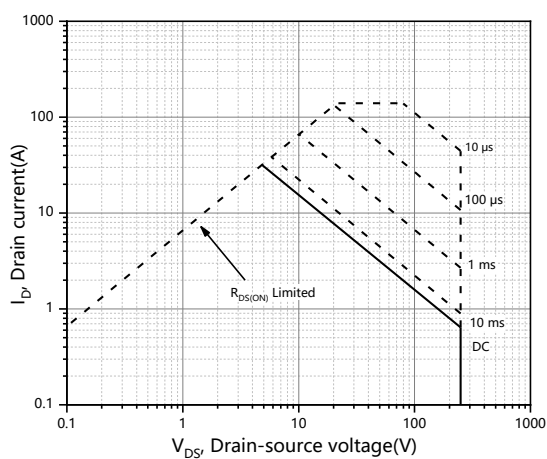


Figure 11. Safe operation area $T_C=25^{\circ}\text{C}$

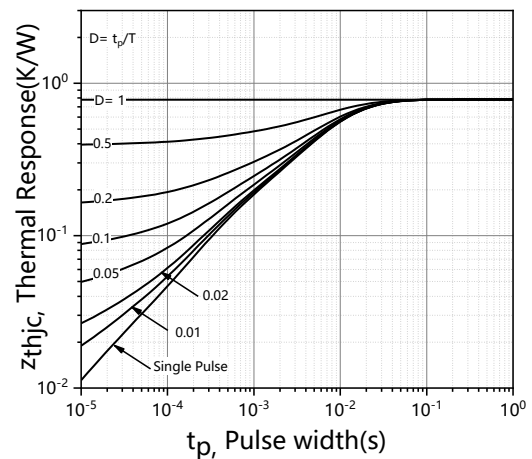


Figure 12. Max. transient thermal impedance

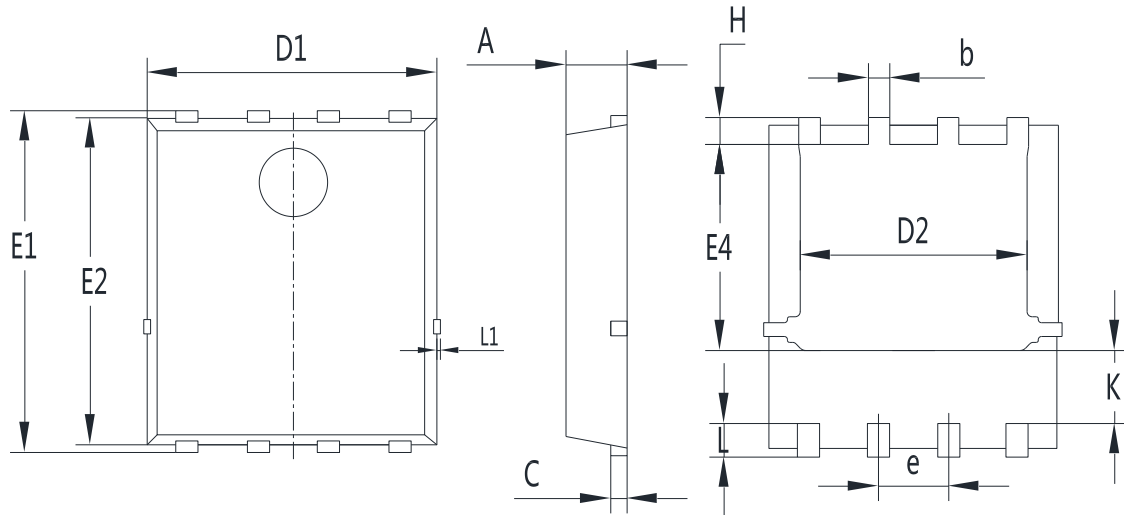
The circuit diagram on the left shows a MOSFET (DUT) in a common-source configuration. The gate is driven by a square-wave pulse V_{gs} through a resistor R_g . The drain is connected to a load resistor R_L and a DC supply V_{dd} through a voltmeter (VDC). The drain voltage V_{ds} is measured across the load resistor. The timing diagram on the right shows the waveforms for V_{gs} and V_{ds} . The V_{gs} pulse has a rise time $t_{r(on)}$, a fall time $t_{f(off)}$, and a total pulse width t_{on} . The V_{ds} waveform shows the voltage across the load resistor during the switching transitions, with the 90% and 10% levels marked for timing measurements.

[illegible]

Figure 1: Schematic diagram and waveforms for the proposed test method. The schematic shows a DUT (Diode Under Test) in series with an inductor L and a VDC source. The gate of the MOSFET is driven by V_{gs} , and the drain is connected to V_{ds} . The source is connected to ground. The current I_{ds} is measured. The waveforms show V_{gs} , I_{ds} , and V_{ds} over time. V_{gs} is a pulse. I_{ds} shows a ramp up (dI/dt) and a reverse current (I_{rm}) during the turn-off phase. V_{ds} shows a voltage spike during the turn-off phase. The formula $Q_{rr} = \int I_{ds} dt$ is shown.

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Package Information



Symbol	mm		
	Min	Nom	Max
A	1.00	1.10	1.20
b	0.30	0.40	0.50
c	0.154	0.254	0.354
D1	5.00	5.20	5.40
D2	3.80	4.10	4.25
e	1.17	1.27	1.37
E1	5.95	6.15	6.35
E2	5.66	5.86	6.06
E4	3.52	3.72	3.92
H	0.40	0.50	0.60
L	0.30	0.60	0.70
L1	0.12 REF		
K	1.15	1.30	1.45

Version 1: PDFN5×6-P package outline dimension

Ordering Information

Package Type	Units/ Reel	Reels/ Inner Box	Units/ Inner Box	Inner Boxes/ Carton Box	Units/ Carton Box
PDFN5 x 6-P	5000	2	10000	5	50000

Product Information

Product	Package	Pb Free	RoHS	Halogen Free
SFS25R60GNF	PDFN5×6	yes	yes	yes

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